

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/586,134 MICHL ET AL.	
		Examiner	Art Unit	Page 1 of 1 Karuna P. Reddy

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 60163914 A	08-1985	Japan	FUJIOKA et al.	C08G 18/67
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